

REPORT NO. Q2003Y-021

Hitachi, Ltd.

**OPERATION TEST REPORT ON TDK CERAMIC RESONATOR**

(FCR10.0MC5)

IC HD641F7145F50 (Hitachi)

JAN, 31, 2003

Sensors & Actuators Division,

TDK CORPORATION

ISSUED BY Chikako Tomizawa

APPROVED	CHECKED	CHECKED
I.Katoh		

## 1. Contents

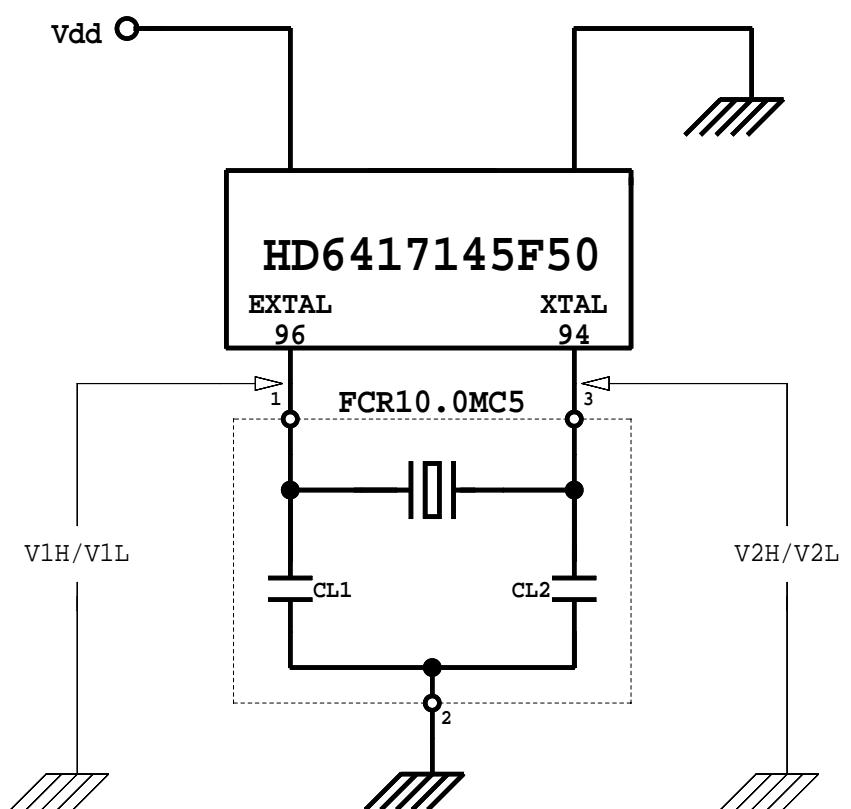
(1) Oscillating circuit for evaluation	P.3
(2) Power supply voltage dependence of oscillating characteristics	P.5
(3) Temperature dependence of oscillating characteristics	P.6-7
(4) Open loop characteristics	P.8-9

## 2. Conclusions

We could confirm the operation satisfactory under  
the following test conditions.

### Test Conditions

IC	:	HD6417145F50 (Hitachi)
Ceramic Resonator	:	FCR10.0MC5 (Typical and worst sample are tested)
Power Supply Voltage	:	3.0(V) ~ 3.6(V)
Temperature Range	:	-20(°C) ~ 75(°C)



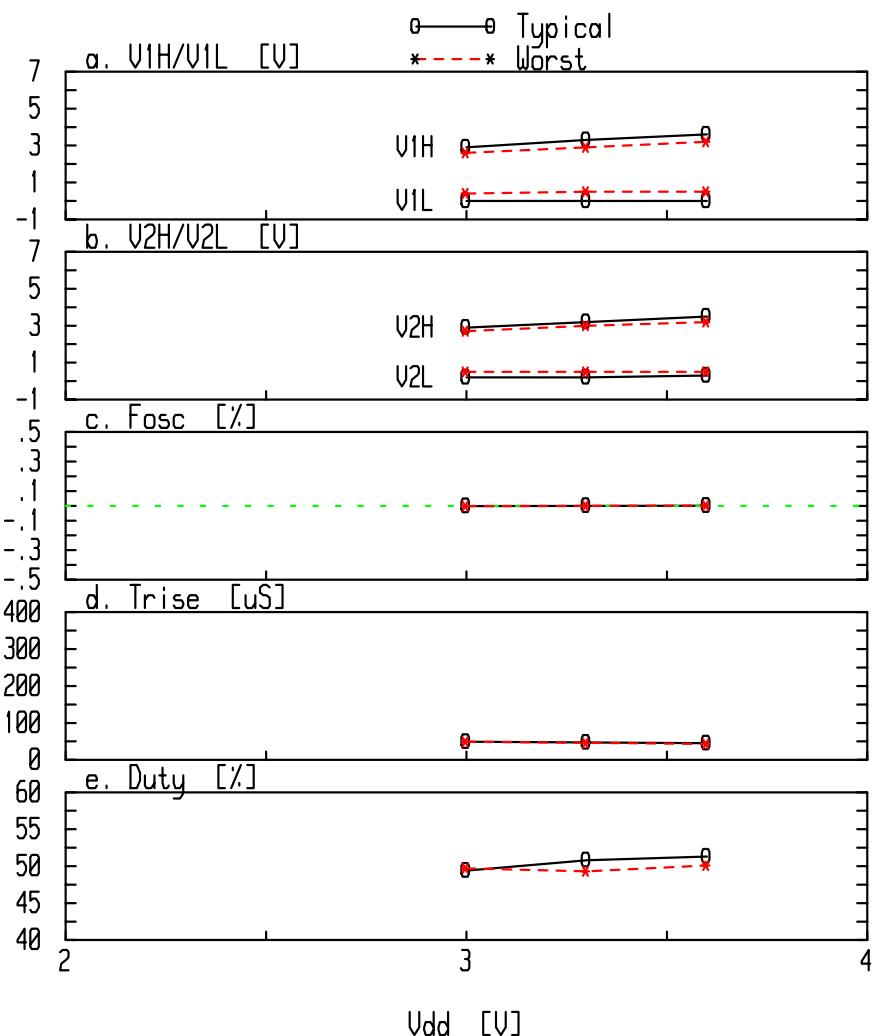
\*BUILT-IN LOADING CAPACITOR  
 $CL1/CL2 = 20/20\text{pF} \pm 20\%$

Oscillating circuit for evaluation

HD6417145F50 - S#209

FCR10.0MC5

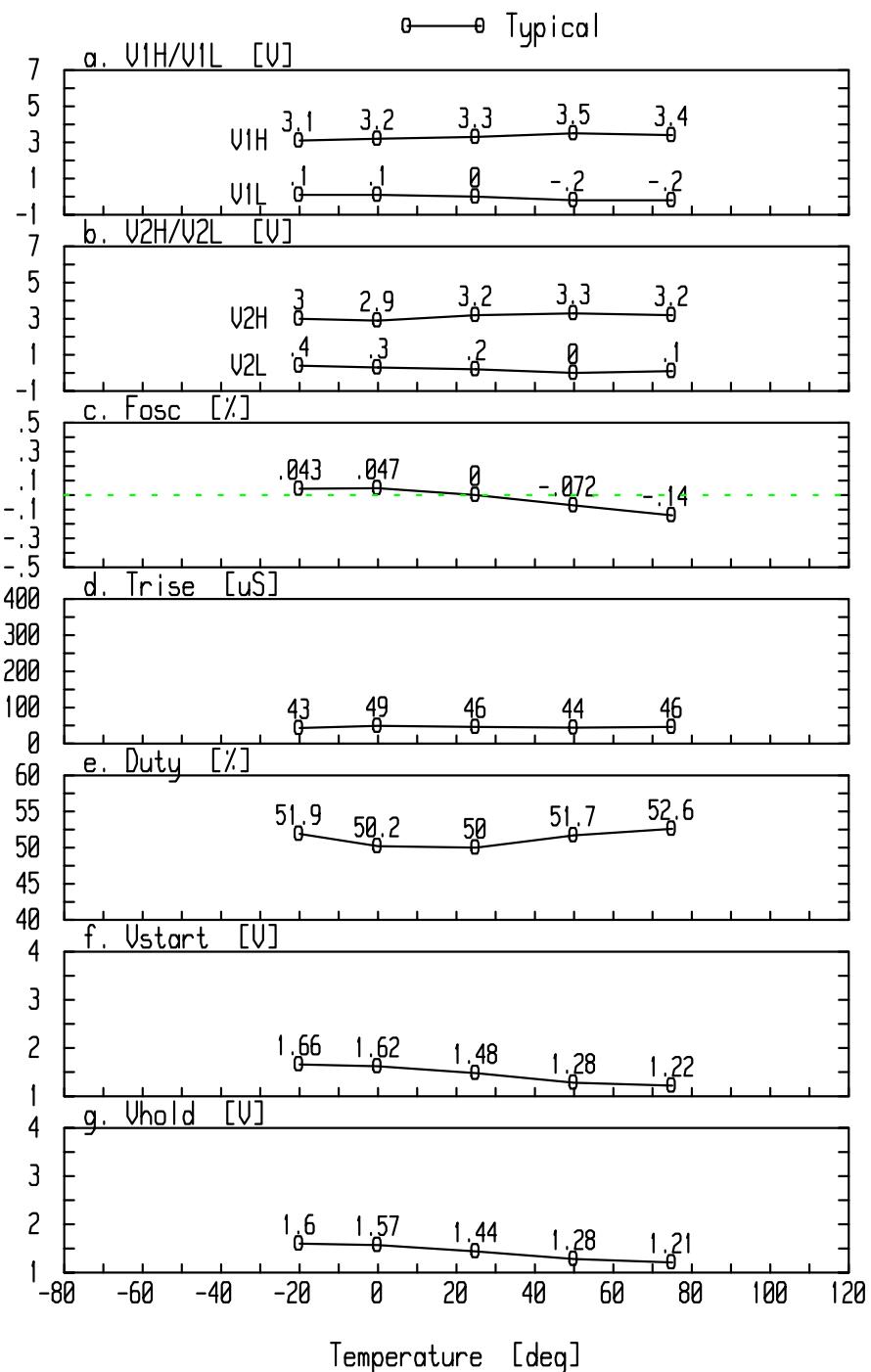
T<sub>a</sub> = 25 [deg]



Power supply voltage dependence of oscillating characteristics

HD6417145F50 - S#209

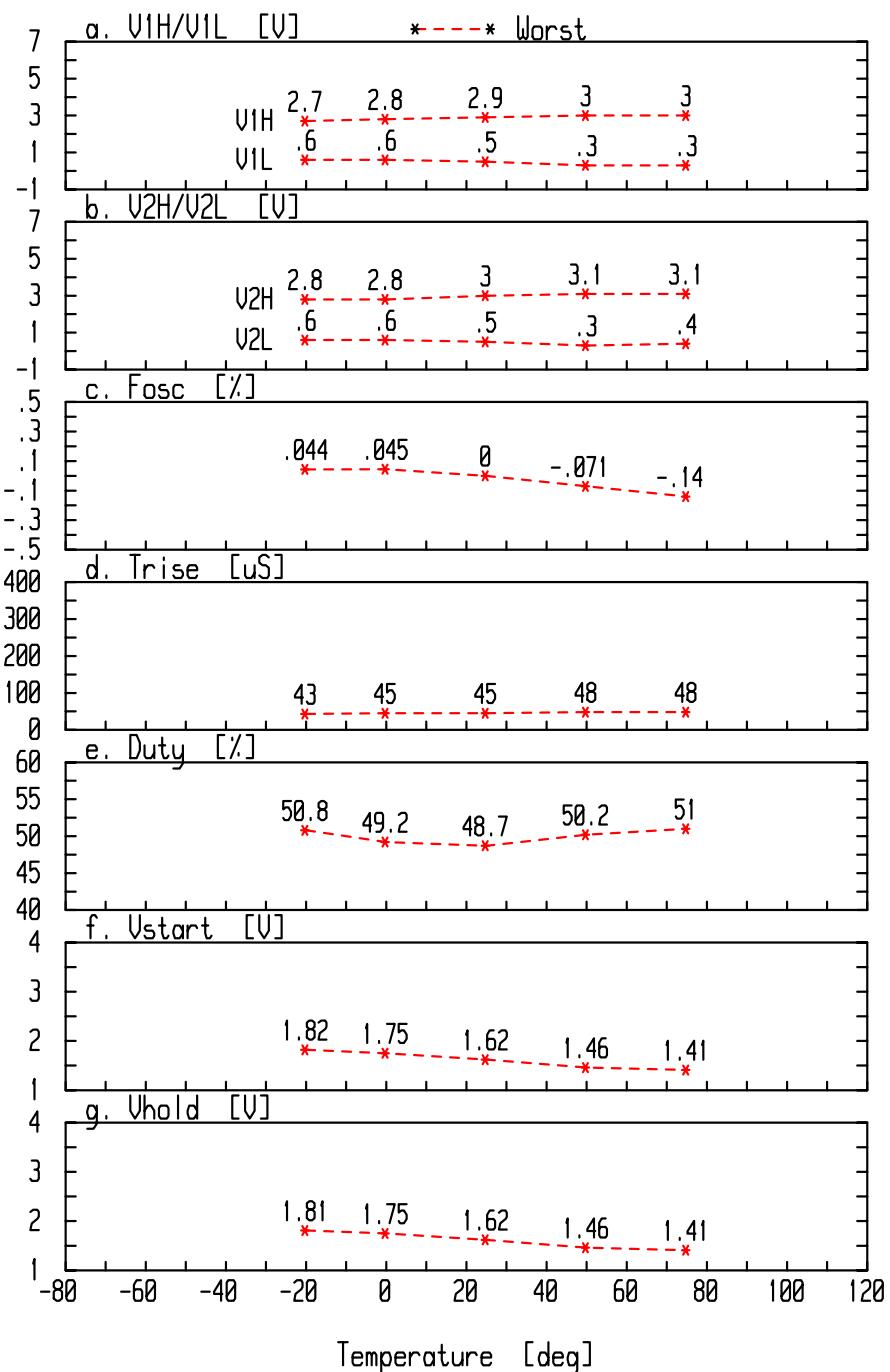
FCR10.0MC5  
 $V_{dd} = 3.3$  [V] (Fig.a~e)



Temperature dependence of oscillating characteristics

HD6417145F50 - S#209

FCR10.0MC5  
 $V_{dd} = 3.3$  [V] (Fig.a~e)



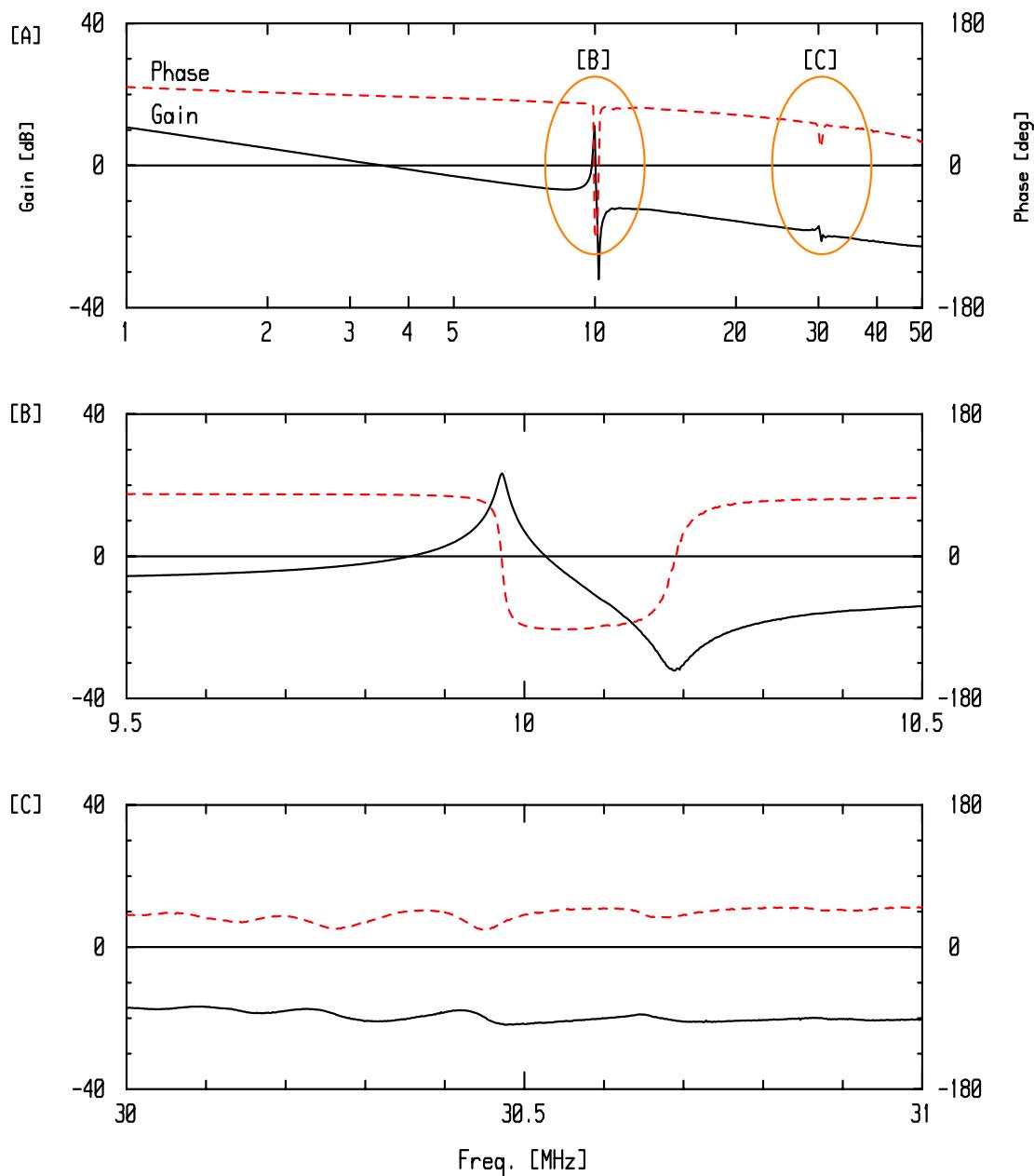
Temperature dependence of oscillating characteristics

HD6417145F50 - S#209

FCR10.0MC5 - Typical

Vdd [V] 3.3

	[B]	[C]
Gmax [dB]	23.33	-16.73
LGM [dB]	23.03	0
FLGM [MHz]	9.972	0
LPM [deg]	-91.83	30.64



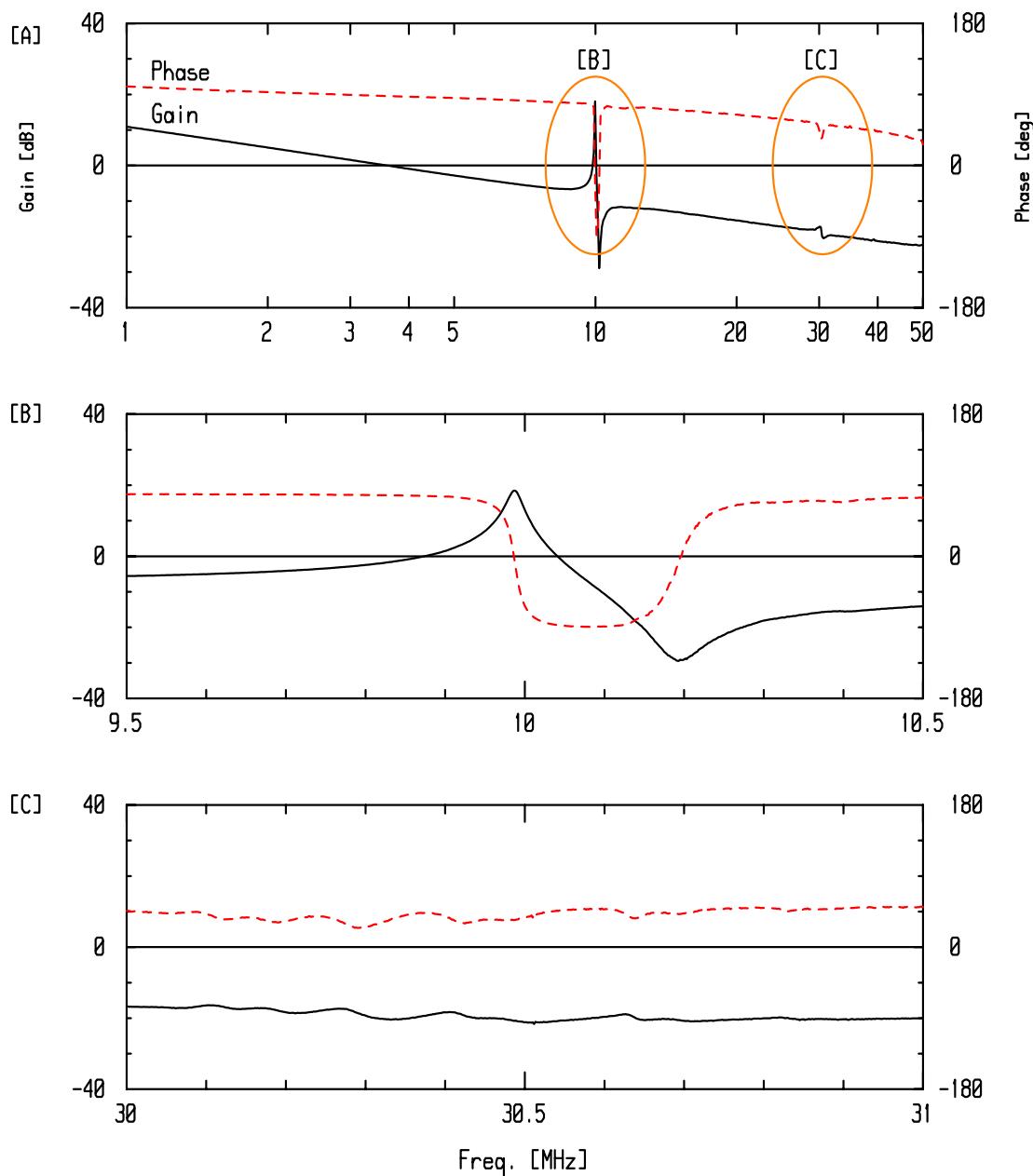
Open loop characteristics (Typical Sample)

HD6417145F50 - S#209

FCR10.0MC5 - Worst

Vdd [V] 3.3

	[B]	[C]
Gmax [dB]	18.5	-16.36
LGM [dB]	18.34	0
FLGM [MHz]	9.9871	0
LPM [deg]	-87.05	34.33



Open loop characteristics (Worst Sample)